

Edition 2.0 2017-06

INTERNATIONAL STANDARD





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Universal serial bus interfaces for data and power – Part 1-2: Common components – USB Power Delivery specification

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Part 1-2: Common components - USB Power Delivery specification

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This second edition cancels and replaces the first edition published in 2016 and constitutes a technical revision.

The text of this standard was prepared by the USB Implementers Forum (USB-IF). The structure and editorial rules used in this publication reflect the practice of the organization which submitted it.

The text of this standard is based on the following documents:

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Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

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The IEC 62680 series is based on a series of specifications that were originally developed by the USB Implementers Forum (USB-IF). These specifications were submitted to the IEC under the auspices of a special agreement between the IEC and the USB-IF.

This standard is the USB-IF publication USB Power Delivery Specification Revision 3.0 V.1.0a and ECNs as of 2 August 2016.

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Universal Serial Bus Power Delivery Specification

Revision 3.0, V1.0a. 25 March 2016 + ECNs 2 August 2016

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			DRP and DRD bits in Capabilities Messages			
			Wait Timing			
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			 vSafe5V Voltage Range Clarification 			
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			NoResponseTimer			
			Specification Revision Interoperability			